

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination KUO, SHEN-CHUN	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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**FOREIGN PATENT DOCUMENTS**

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N		EP-0 113 570-A1	07-1984	EP	Chabala et al.	
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**NON-PATENT DOCUMENTS**

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